Search	n Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/711,280	SHEI ET AL.
Examiner	Art Unit
DUNG A. LE	2818

SEARCHED				
Class	Subclass	Date	Examiner	
257	737-738	11/19/2007	DLE	
257	778	11/19/2007	DLE	
438	612-613	11/19/2007	DLE	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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interferen	ce search	11/19/2007	DLE

SEARCH   (INCLUDING SEAR	NOTES CH STRATEGY	)
	DATE	EXMR
updated search 257/E21.508-E21.511	11/19/2007	DLE
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